Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/900,168	KAMIYA, AKIRA		
Examiner	Art Unit		
Richard Lee	2621		

SEARCHED					
Class	Subclass	Date	Examiner		
Updated	Search	10/20/2006	RL		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH N (INCLUDING SEARC	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
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